



Nemko

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RSS-210 PARA. 6.2.2.

DECLARATION OF CONFORMANCE PROCEDURES
TEST REPORT

For The **Wireless Turn Signal**

Model: **TurnSmart Model 30001**

PREPARED FOR:

Auto Care Products
6345 Nancy Ridge Drive
San Diego, CA 92121

PREPARED ON AUGUST 17, 2004

REPORT NUMBER 2004 080535 IC

PROJECT NUMBER: 24-535-AUT



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DOCUMENT HISTORY

REVISION	DATE	COMMENTS
-	August 17, 2004	Prepared By: Alan Laudani
-	August 17, 2004	Initial Release: R. L. Hill
Pg 19, 20	Oct. 28, 2004	Revised by Alan Laudani

NOTE: Nemko USA, Inc. hereby makes the following statements so as to conform to Chapter 10 (Test Reports) Requirements of ANSI C63.4 (2002) "Methods and Measurement of Radio-Noise Emissions from Low-Voltage Electrical and Electronic Equipment in the Range of 9 kHz to 40 GHz":

- The unit described in this report was received at Nemko USA, Inc.'s facilities on **August 17, 2004**. Testing was performed on the unit described in this report on **August 17, 2004 to** August 17, 2004.
- The Test Results reported herein apply only to the Unit actually tested, and to substantially identical Units.
- This report does not imply the endorsement of the Federal Communications Commission (FCC), NVLAP or any other government agency.

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CERTIFICATION

Nemko USA, Inc., an independent Electromagnetic Compatibility (EMC) Test Laboratory, produced this Test Report and performed the Radio Frequency Interference (RFI) testing and data evaluation contained herein.

Nemko USA, Inc.'s measurement facility is currently registered with the United States Federal Communications Commission (FCC) in accordance with the provisions of 47 United States Code (CFR) Part 2, Subpart I, Section 2.948(a). A current description of Nemko USA, Inc.'s measurement facility is on file with the FCC. Nemko USA Inc. has additionally satisfied the FCC that it complies with the requirements set forth in 47 CFR Part 2, Subpart I, Section 2.948(d) regarding the accreditation of EMC laboratories. As a result, the FCC has placed Nemko USA Inc. on its list of EMC laboratories approved to perform Declaration of Conformity (DOC) procedure testing.

The RFI testing, test data collection and test data evaluation were accomplished in accordance with the ANSI C63.4-2002 Standard, and in accordance with the applicable sections of the FCC rules (47 CFR Parts 2 and 15) for Class "A" digital devices. The testing was also accomplished in accordance with Industry Canada's ICES-003 standard for unintentional radiating device per EMCAB-3, Issue 3 (May 1998). The administrative summary of this test report provides a description of the test sample.

I hereby certify that the test data, test data evaluation, and equipment configurations used to compile this test report are a true and accurate representation of the test sample's radio frequency interference characteristics as of the test date(s), and, for the design of the test sample.

Ricky L. Hill
Manager of EMC Operations

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1. ADMINISTRATIVE DATA AND TEST SUMMARY

1.1. Administrative Data

CLIENT: Auto Care Products
6345 Nancy Ridge Drive
San Diego, CA 92121
858 625-0005 x11
858 625-0010- fax

CONTACT: Ric Perlman

DATE (S) OF TEST: August 17, 2004 to August 17, 2004

EQUIPMENT UNDER TEST (EUT): Wireless Turn Signal

Model TurnSmart Model 30001

Condition Upon Receipt Suitable for Test

TEST SPECIFICATION: RSS-210 Low Power License-Exempt Radio-communication Devices (All Frequency Bands)

1.2. Test Summary

<i>Specification</i>	<i>Frequency Range</i>	<i>Compliance Status</i>
RSS-210 conducted Emissions	0.45 MHz - 30.00 MHz	N/A
RSS-210 para. 6.2.2.(1) Field Strength RSS-210 para. 6.3 Restricted bands and unwanted emission frequencies	30MHz – 10 th Harmonic	PASS
RSS-210 Occupied Bandwidth	902-928 MHz	PASS

Test Supervisor:

CR FLEURY

CR Fleury

Refer to the test results section for further details.



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2.SYSTEM CONFIGURATION

2.1. Description and Method of Exercising the EUT

The TurnSmart Model 30001 is a Wireless Turn Signal. Its function is transmit an automobile driver's signals (brake light, left/right turn signals using RF energy to the receiver located on the trailer. EUT was exercised by the provided test fixture to transmit continuously

2.2. System Components and Power Cables

EUT is powered by internal battery or vehicle 12 Vdc supply. Device has no interconnection or I/O cables.

2.3. Test Configuration

The TurnSmart Model 001 was set up and controlled by a test fixture to continuously transmit at the maximum power setting at the desired, designated frequency with the integral antenna. Test of the fundamental frequency and all measurable harmonics was performed during this evaluation.

2.4. Design Modifications for Compliance

Device: Wireless Turn Signal

Model: TurnSmart Model 30001

The following design modifications were made to the EUT during testing.

No design modifications were made to the EUT during testing.



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3. DESCRIPTION OF TEST SITE AND EQUIPMENT

3.1. Description of Test Site

The test site is located at 11696 Sorrento Valley Road, Suite F, San Diego, CA 92121. The site is physically located 18 miles Northwest of downtown San Diego. The general area is a valley 1.5 miles east of the Pacific Ocean. This particular part of the valley tends to minimize ambient levels, i.e. radio and TV broadcast stations and land mobile communications. The three and ten-meter Open Area Test Site (OATS) is located behind the office/lab building. It conforms to the normalized site attenuation limits and construction specifications as set in the EN 55022 (1998), CISPR 16 (2000) and 22 (1997) and ANSI C63.4-2002 documents. The OATS normalized site attenuation characteristics are verified for compliance every.



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4. DESCRIPTION OF TESTING METHODS

4.1. Introduction

As required in 47 CFR, Parts 2 and 15, the methods employed to test the radiated and conducted emissions (as applicable) of the EUT are those contained within the American National Standards Institute (ANSI) document C63.4-2002, titled "Methods of Measurement of Radio-Noise Emissions from Low-Voltage Electrical and Electronic Equipment in the Range of 9 kHz to 40 GHz." All applicable FCC Rule Sections that provide further guidance for performance of such testing are also observed.

For General Test Configuration please refer to Figure 1 on the following page.

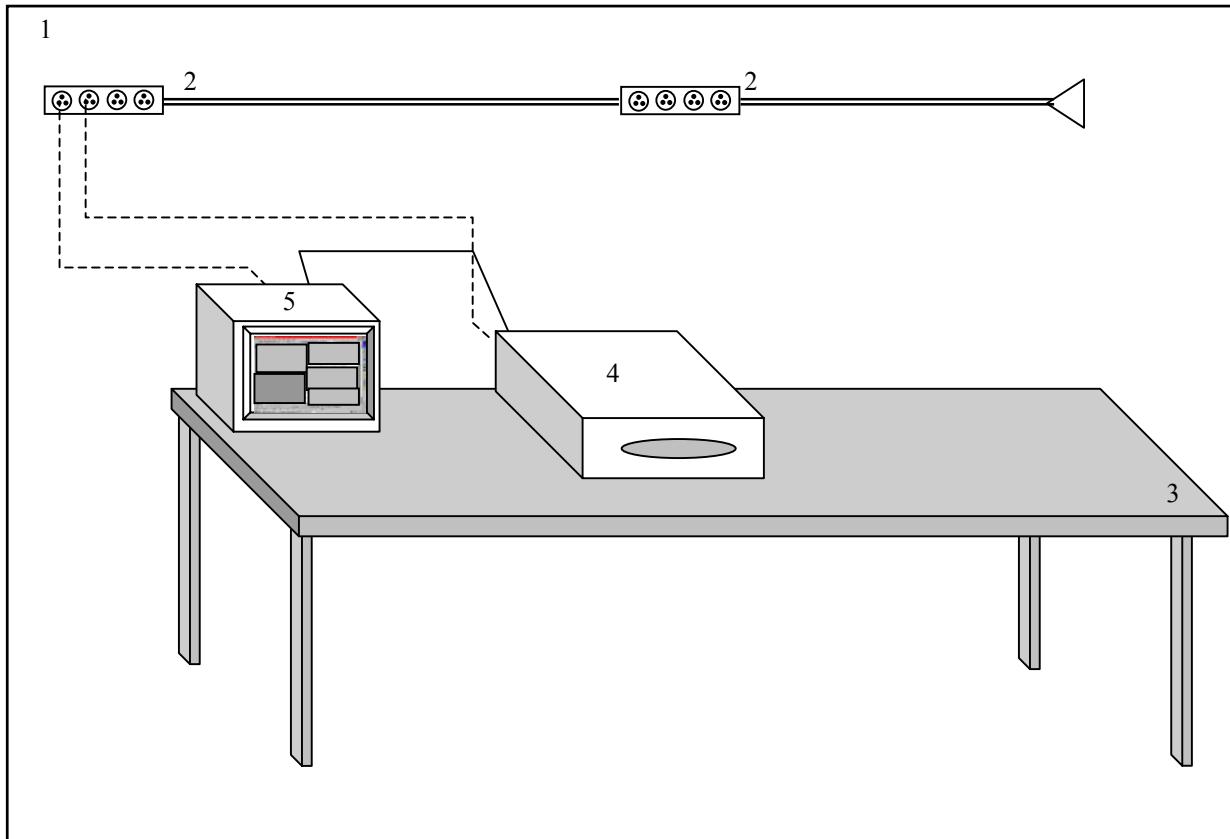
Digital devices sold in Canada are required to comply with the Interference Causing Equipment Standard for Digital Apparatus, ICES-003. These test methods and limits are specified in the Canadian Standards Association's (CSA) Standard C108.8-M1983 (1-1-94 version) and are "essentially equivalent" with FCC, Part 15 and CISPR 22 (EN55022) rules for unintentional radiators per EMCAB-3, Issue 3 (May 1998). No further testing is required for compliance to ICES-003.



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Figure 1. General EUT Test Setup Diagram



NOT TO SCALE

CONFIGURATION LEGEND

1. Test Laboratory
2. AC Power for Peripheral Devices (120V, 60 cycles, single phase)
3. Non-Conducting tables 80 cm above ground plane
4. EUT: Wireless Turn Signal



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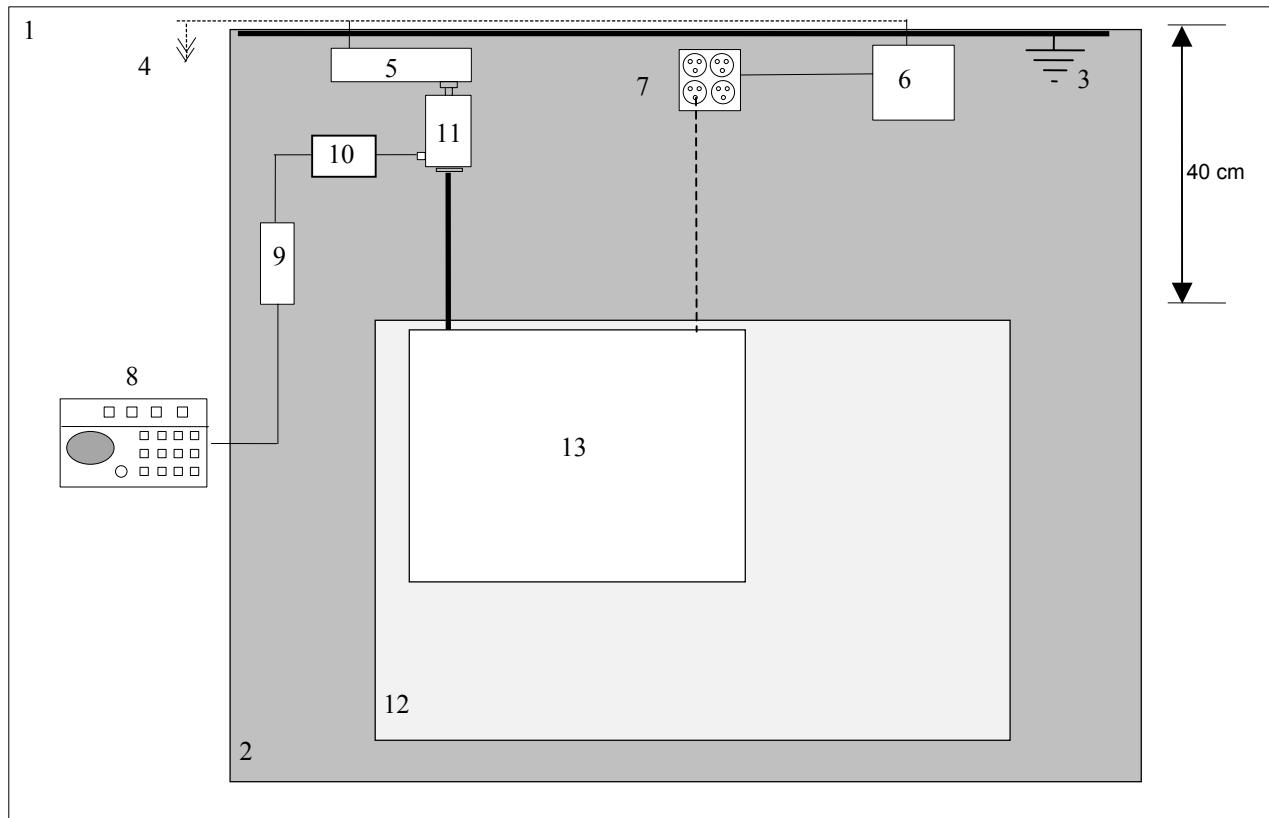
4.2. Configuration and Methods of Measurements for Conducted Emissions

Section 7 of ANSI C63.4 determines the general configuration of the EUT and associated equipment, as well as the test platform for conducted emissions testing. Tabletop devices are placed on a non-conducting surface 80 centimeters above the ground plane floor and 40 centimeters from the ground plane wall. The EUT and associated system are configured to operate continuously, representing a “normally operating” mode. The EUT is powered via a Line Impedance Stabilization Network (LISN). The emissions are recorded using the required bandwidth of 9 kHz in the quasi-peak mode. The average amplitude is also observed employing a 10 kHz bandwidth to determine the presence of broadband RFI. When such interference is caused by broadband sources (as defined by the FCC and ANSI Rules), the deviation guidelines contained in Section 11.3.1 of ANSI C63.4 are employed, which allows a correction factor of 13 dB to be subtracted from the quasi-peak reading. The emission levels are then compared to the applicable FCC limits to determine compliance.

For Conducted Emissions Test Configuration please refer to Figure 2 on the following page.



Figure 2. Conducted Emissions Test Setup Diagram



NOT TO SCALE

CONFIGURATION LEGEND

1. Test Laboratory (6 X 6 meters)
2. Ground Plane (15 square meters)
3. Vertical Conducting Wall (Grounded through Ground Plane via 10' ground rod)
4. AC Power for Devices
5. Power Line Filter, Lindgren, 120 dB, 30 amp
6. Line Impedance Stabilization Network (LISN) for peripheral devices
7. Power Distribution Box for peripheral devices
8. Spectrum Analyzer with Quasi-Peak Adapter
9. High Pass Filter
10. Transient Limiter
11. LISN for EUT
12. Non-Conducting table 80 cm above ground plane
13. EUT: Wireless Turn Signal and Associated System



4.3. Configuration and Methods of Measurements for Frequency Identification

When performing all testing of equipment, the actual emissions of the EUT are segregated from ambient signals present within the laboratory or the open-field test range. Preliminary testing is performed to ensure that ambient signals are sufficiently low to allow for proper observation of the emissions from the EUT. Incoming power lines are filtered using a 120 dB, 30-ampere; 115/208-volt filter to assist in reducing ambient signals for tests of levels of conducted emissions. Ambients within the laboratory are compared to those noted at the nearby open-field site to discriminate between signals produced from the EUT and ambient signals. In the event that a significant emission is produced by the EUT at a frequency which is also demonstrating significant ambient signals, the spectrum analyzer is placed in the peak mode, the bandwidth is narrowed, the EUT's signal is centered on the analyzer, the scan width is expanded to 50 kHz while monitoring the audio to ensure that only the EUT signal is present, the analyzer is switched to quasi-peak mode, and the level of the EUT signal is recorded.

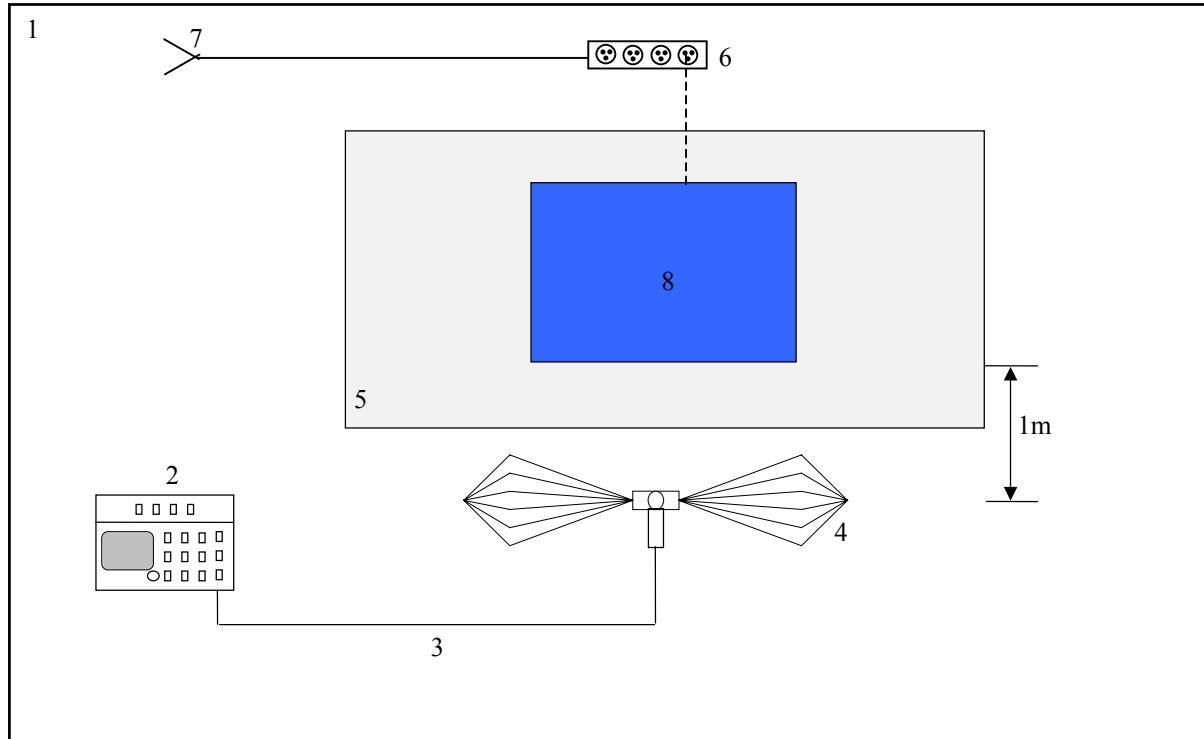
For Frequency ID Test Configuration please refer to Figure 3 on the following page.



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Figure 3. Frequency ID of Radiated Emissions Test Setup Diagram



NOT TO SCALE

CONFIGURATION LEGEND

1. Test Laboratory
2. Spectrum Analyzer with Quasi-Peak Adapter
3. Coax interconnect from Antenna to Spectrum Analyzer
4. Receive Antenna (basic relative position)
5. Non-Conducting table 80 cm above ground plane
6. Power strip for EUT and peripherals
7. AC power for devices
8. EUTWireless Turn Signal and Associated System



4.4. Configuration and Methods of Measurements for Radiated Emissions

Section 8 of ANSI C63.4 determines the general configuration and procedures for measuring the radiated emissions of equipment under test. Initially, the primary emission frequencies are identified inside the test lab by positioning a broadband receive antenna one meter from the EUT to locate frequencies of significant radiation. Next, the EUT and associated system are placed on a turntable on a ten meter open area test site (registered with the FCC in accord with its Rules and ANSI C63.4) and the receive antenna is located at a distance of ten meters from the EUT.

The EUT and associated system are configured to operate continuously, representing a “normally operating” mode. All significant radiated emissions are recorded when maximum radiation on each frequency is observed, in accordance with part 8 of ANSI C63.4-1992 and Section 15.33 of the FCC Rules. To ensure that the maximum emission at each discrete frequency of interest is observed, the receive antenna is varied in height from one to four meters and rotated to horizontal and vertical polarities, and the turntable is also rotated to determine the worst emitting configuration. The numerical results of the test are included herein to demonstrate compliance.

The numerical results that are applied to the emissions limits are arrived at by the following method:

Example: $A = RR + CL + AF$

A = Amplitude dBuV/M

RR = Receiver Reading dBuV

CL = cable loss dB

AF = antenna factor dBm-1

Example Frequency = 110MHz

18.5 dBuV (spectrum analyzer reading)

+3.0 dB (cable loss @ frequency)

21.5 dBuV

+15.4 dBm-1 (antenna factor @ frequency)

36.9 dBuV/M Final adjusted value

The final adjusted value is then compared to the appropriate emission limit to determine compliance.

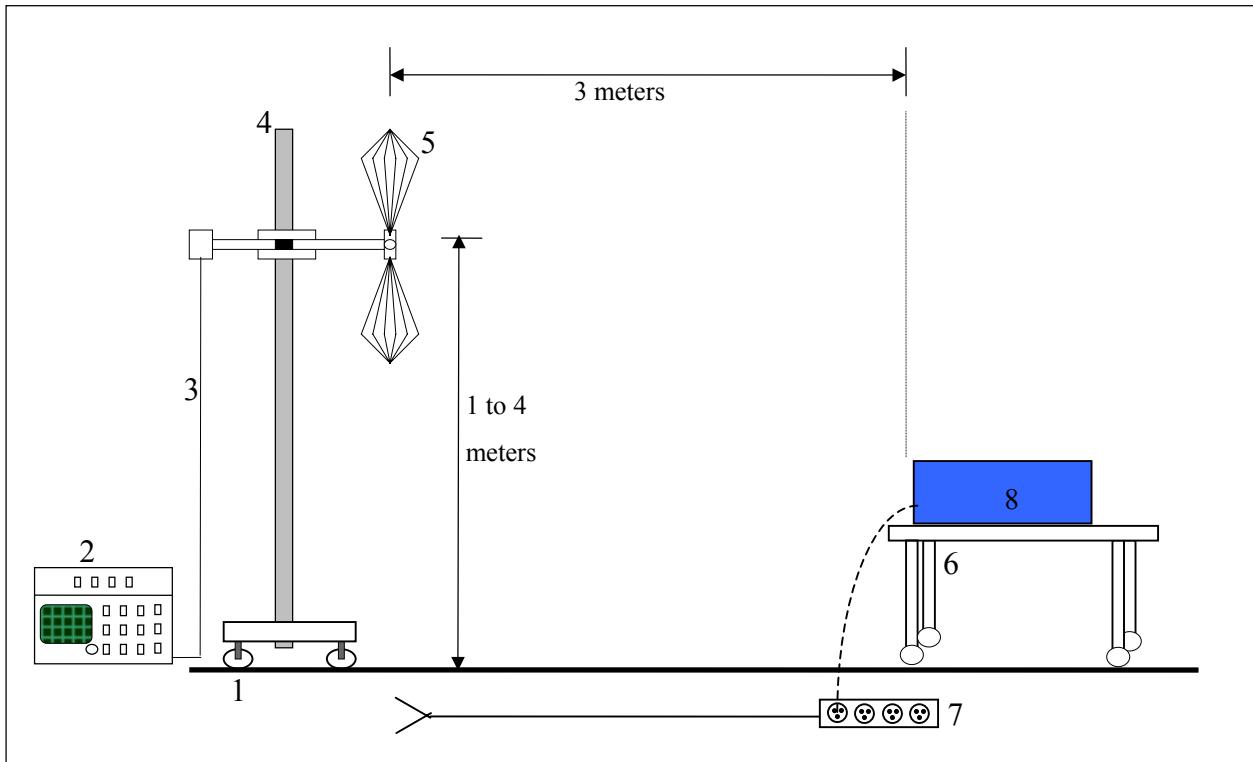
For Radiated Emissions Test Configuration please refer to Figure 4 on the following page.



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Figure 4. Radiated Emissions Test Setup Diagram



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CONFIGURATION LEGEND

1. Ground plane (11 X 17 meters)
2. Spectrum Analyzer with Quasi-Peak Adapter
3. Coax interconnect from Receive Antenna to Spectrum Analyzer
4. Antenna Mast with motorized mounting assembly
5. Receive Antenna (basic relative position)
6. Non-Conducting table 80 cm above ground plane
7. AC power for devices
8. EUT: Wireless Turn Signal and Associated System



4.5. Operation in the 15.249 bands.

In Addition to the general radiated emissions requirements described in RSS-210 paragraph 6.2.2 determines the configuration and procedures for measuring additional emissions of Low Power License-Exempt Radiocommunication Devices (All Frequency Bands)

Intentional Radiating Devices.

The following table is a summary of the testing requirements from CFR 47, Section 15.249, performed for the EUT certification testing.

RSS-210 Paragraph #	
6.2.2 (1) Field Strength and Radiated Emissions	Accomplished/PASS
6.3 Restricted Bands and Unwanted Emission Frequencies	Accomplished/PASS
6.4 Frequency Stability – Not applicable as carrier frequency lies totally within the band 902-928 MHz.	Accomplished/PASS
6.6 AC Wireline Conducted Measurement Method – EUT is powered by vehicle 12 Vdc supply or battery.	NA
8. Receiver Mode— Not applicable as EUT is Category II. as it is non-tunable.	NA
Occupied Bandwidth (-26 dB Bandwidth).	Accomplished/PASS



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5. TEST RESULTS

5.1. Conducted Emissions Test Data

N/A

5.2. Conducted Emissions Test Equipment

N/A



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5.3. CFR 47 Part 15C §15.249 Test Results



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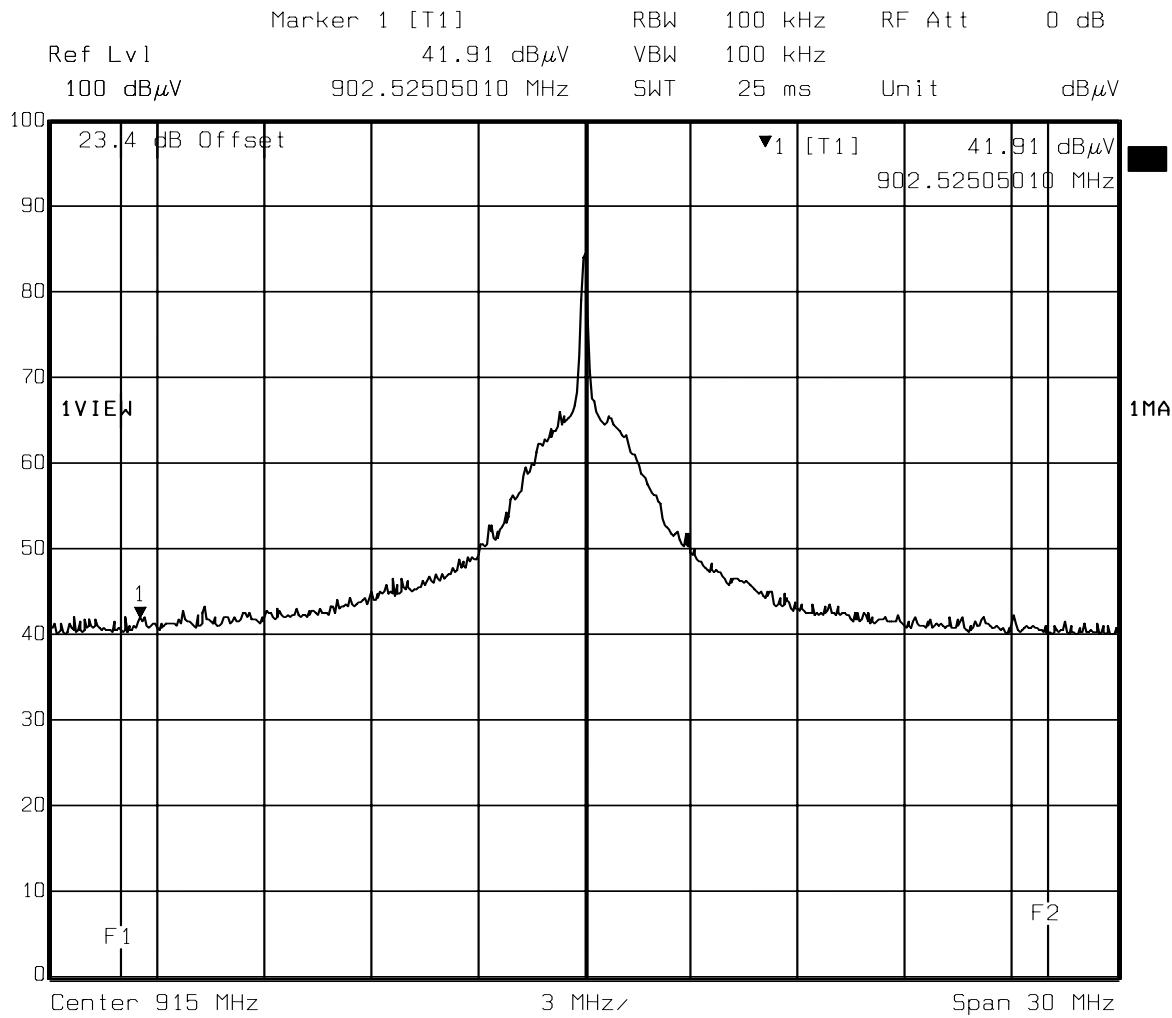
Radiated Emissions Test Equipment

Client	Auto Care Products	EUT Name	Wireless Turn Signal		
PAN #	24-535-AUT	EUT Model	TurnSmart Model 30001		
Device Type	Model #	Asset #	Serial Number	Cal Done	Cal Due
Antenna OATS #1 (South)					
Spectrum Analyzer, Rhd & Schw.	1088.3494.30	835	829058/005	12-11-03	12-11-04
Antenna, Log Periodic, EMCO	3146	112	9101-2988	9-19-03	9-19-04
Antenna, Ridged Guide, EMCO	3115	529	2505	3-30-04	3-30-05
Amplifier, 40dB Miteq	40 dB	171	NA	NA	NA
Cable, Micropore	60 ft.	NA	NA	NA	NA
Quasi Peak Adapter	85650A	421	3145A01672	10/26/03	10/26/04
Spectrum Analyzer	8568B	422	2517A01757	10/26/03	10/26/04
Preamplifier	ZHL-Z	635	NA	3/3/04	3/3/05
DC Power Supply	XT60-1	Na	NA	NA	NA
Multimeter	3478A	265	2301A11706	10-16-03	10-16-04



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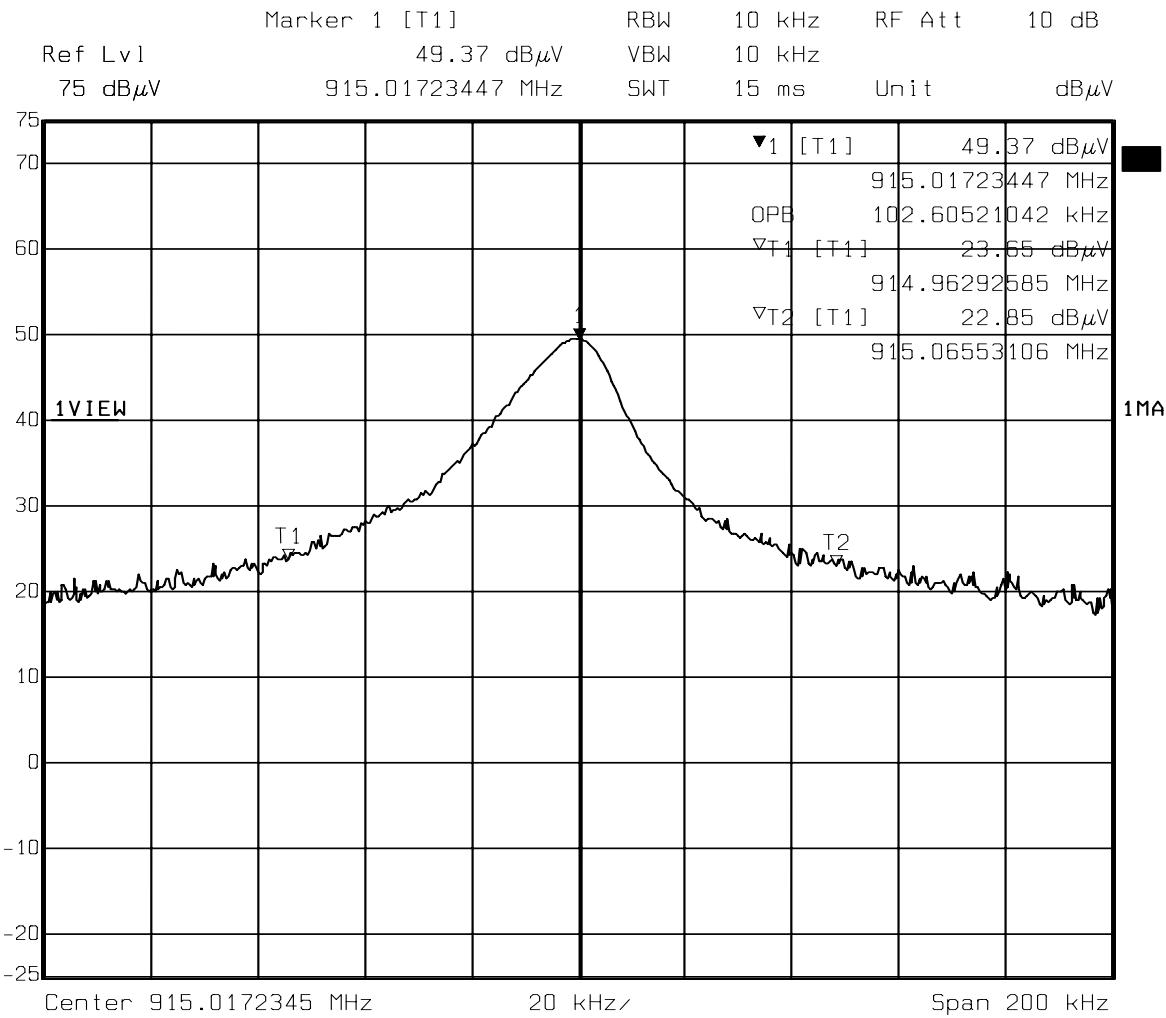
Date: 27.AUG.2004 08:28:06

Band Edge Compliance: 902-928 MHz Showing no emissions within 40 dBc at band edge.



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Photograph 1. Radiated Emissions Test Configuration



1. Log Periodic Antenna
2. EUT: **Wireless Turn Signal**

Photograph 2. Front View of EUT





APPENDIX A

A. Conducted & Radiated Emissions Measurement Uncertainties

1. Introduction

ISO Standard 17025 and ANSI/NCSL Z540-1(1994) require that all measurements contained in a test report be "traceable". "Traceability" is defined in the *International Vocabulary of Basic and General Terms in Metrology* (ISO: 1993) as: "the property of the result of a measurement... whereby it can be related to stated references, usually national or international standards, through an unbroken chain of comparisons, *all having stated uncertainties*".

The purposes of this Appendix are to "state the *Measurement Uncertainties*" of the conducted emissions and radiated emissions measurements contained in Section 5 of this Test Report, and to provide a practical explanation of the meaning of these measurement uncertainties.

2. Statement of the Worst-Case Measurement Uncertainties for the Conducted and Radiated Emissions Measurements Contained in This Test Report

Table 1: Worst-Case Expanded Uncertainty "U" of Measurement for a k=2 Coverage Factor

Conducted Emissions Measurement Detection Systems	Applicable Frequency Range	"U" for a k=2 Coverage Factor
HP8568B Spectrum Analyzer with QPA and HP8447F Preamplifier	150 kHz - 30 MHz	+/- 3.0 dB
HP8566B Spectrum Analyzer with QPA and Preselector	9 kHz - 30 MHz	+/- 2.9 dB
Radiated Emissions Measurement Detection Systems	Applicable Frequency Range	"U" for a k=2 Coverage Factor
HP8568B Spectrum Analyzer with QPA & HP8447F Preamplifier	30 MHz - 200 MHz	+4.0 dB, -4.1 dB
HP8568B Spectrum Analyzer with QPA & HP8447F Preamplifier	200 MHz-1000 MHz	+/- 3.5 dB
HP8566B Spectrum Analyzer with QPA & Preselector	30 MHz - 200 MHz	+3.9 dB, -4.0 dB
HP8566B Spectrum Analyzer with QPA & Preselector	200 MHz-1000 MHz	+/- 3.4 dB
HP8566B Spectrum Analyzer with QPA & HP 8449A Preamplifier	1 GHz - 18 GHz	+2.5 dB, -2.6 dB
HP8566B Spectrum Analyzer with QPA & HP8449A Preamplifier	18 GHz - 40 GHz	+/- 3.4 dB

NOTES:

1. Applies to 3 and 10 meter measurement distances
2. Applies to all valid combinations of Transducers (i.e. LISNs, Line Voltage Probes, and Antennas, as appropriate)
3. Excludes the Repeatability of the EUT



3. Practical Explanation of the Meaning of the Conducted and Radiated Emissions Measurement Uncertainties

In general, a “Statement of Measurement Uncertainty” means that with a certain (specified) confidence level, the “true” value of a measurand will be between a (stated) upper bound and a (stated) lower bound.

In the specific case of EMC Measurements in this test report, the measurement uncertainties of the conducted emissions measurements and the radiated emissions measurements have been calculated in accordance with the method detailed in the following documents:

- *ISO Guide to the Expression of Uncertainty in Measurement* (ISO, 1993)
- *NIS 81:1994, The Treatment of Uncertainty in EMC Measurements* (NAMAS, 1994)
- *NIST Technical Note 1297(1994), Guidelines for Evaluating and Expressing the Uncertainty of NIST Measurement Results* (NIST, 1994)

The calculation method used in these documents requires that the stated uncertainty of the measurements be expressed as *an “expanded uncertainty”, U , with a $k=2$ coverage factor*. The practical interpretation of this method of expressing measurement uncertainty is shown in the following example:

EXAMPLE: Assume that at 39.51 MHz, the (measured) radiated emissions level was equal to +26.5 dBuV/m, and that the +/- 2 standard deviations (i.e. 95% confidence level) measurement uncertainty was +/- 3.4 dB.

In the example above, the phrase “ $k = 2$ Coverage Factor” simply means that the measurement uncertainty is stated to cover +/- 2 standard deviations (i.e. a 95% confidence interval) about the measurand. The measurand is the radiated emissions measurement of +26.5 dBuV/m at 39.51 MHz, and the 95% bounds for the uncertainty are -3.4 dB to + 3.4 dB. One can thus be 95% confident that the “true” value of the radiated emissions measurement is between +23.1 dBuV/m and +29.5 dBuV/m. *In effect, this means that in the above example there is only a 2.5% chance that the “true” radiated emissions value exceeds +29.5 dBuV/m.*



APPENDIX B

B. Nemko USA, Inc.'s Test Equipment & Facilities Calibration Program

Nemko USA, Inc. operates a comprehensive Periodic Calibration Program in order to ensure the validity of all test data. Nemko USA's Periodic Calibration Program is fully compliant to the requirements of NVLAP Policy Guide PG-1-1988, ANSI/NCSL Z540-1 (1994), ISO 10012-1 (1993-05-01), ISO Standard 17025, ISO-9000 and EN 45001. Nemko USA, Inc.'s calibrations program therefore meets or exceed the US national commercial and military requirements [N.B. ANSI/NCSL Z540-1 (1994) replaces MIL-STD-45662A].

Specifically, all of Nemko USA's *primary reference standard devices* (e.g. vector voltmeters, multimeters, attenuators and terminations, RF power meters and their detector heads, oscilloscope mainframes and plug-ins, spectrum analyzers, RF preselectors, quasi-peak adapters, interference analyzers, impulse generators, signal generators and pulse/function generators, field-strength meters and their detector heads, etc.) and certain *secondary standard devices* (e.g. RF Preamplifiers used in CISPR 11/22 and FCC Part 15/18 tests) are periodically recalibrated by:

- A Nemko USA-approved independent (third party) metrology laboratory that uses NIST-traceable standards and that is ISO Guide 25-accredited as a calibration laboratories by NIST; or,
- A Nemko USA-approved independent (third party) metrology laboratory that uses NIST-traceable standards and that is ISO Guide 25-accredited as a calibration laboratory by another accreditation body (such as A2LA) that is mutually recognized by NIST; or,
- A manufacturer of Measurement and Test Equipment (M&TE), if the manufacturer uses NIST-traceable standards and is ISO Guide 25-accredited as calibration laboratory either by NIST or by another accreditation body (such as A2LA) that is mutually recognized by NIST; or
- A manufacturer of M&TE (or by a Nemko USA-approved independent third party metrology laboratory) that is not ISO Guide 25-accredited. (In these cases, Nemko USA conducts an annual audit of the manufacturer or metrology laboratory for the purposes of proving traceability to NIST, ensuring that adequate and repeatable calibration procedures are being applied, and verifying conformity with the other requirements of ISO Guide 25).



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In all cases, the entity performing the Calibration is required to furnish Nemko USA with a calibration test report and/or certificate of calibration, and a “calibration sticker” on each item of M&TE that is successfully calibrated.

Calibration intervals are normally one year, except when the manufacturer advises a shorter interval (e.g. the HP 8568B Spectrum Analyzer is recalibrated every six months) or if US Government directives or client requirements demand a shorter interval. Items of instrumentation/related equipment which fail during routine use, or which suffer visible mechanical damage (during use or while in transit), are sidelined pending repair and recalibration. (Repairs are carried out either in-house [if minor] or by a Nemko USA-approved independent [third party] metrology laboratory, or by the manufacturer of the item of M&TE).

Each antenna used for CISPR 11 and CISPR 22 and FCC Part 15 and Part 18 radiated emissions testing (and for testing to the equivalent European Norms) is calibrated annually by either a NIST (or A2LA) ISO Standard 17025-Accredited third-party Antenna Calibration Laboratory or by the antenna's OEM if the OEM is NIST or A2LA ISO Standard 17025-accredited as an antenna calibration laboratory. The antenna calibrations are performed using the methods specified in Annex G.5 of CISPR 16-1(1993) or ANSI C63.5-1991, including the “Three-Antenna Method”. Certain other kinds of antennas (e.g. magnetic-shielded loop antennas) are calibrated annually by either a NIST (or A2LA) ISO Standard 17025-accredited third-party antenna calibration laboratory, or by the antenna's OEM if the OEM is NIST or A2LA ISO Standard 17025-accredited as an antenna calibration laboratory using the procedures specified in the latest version of SAE ARP-958.

In accordance with FCC and other regulations, Nemko USA recalibrates its suite of antennas used for radiated emissions tests on an annual basis. These calibrations are performed as a precursor to the FCC-required annual revalidation of the Normalized Site Attenuation properties of Nemko USA's Open Area Test Site. Nemko USA, Inc. uses the procedures given in both Subclause 16.6 and Annex G.2 of CISPR 16-1 (1993), and, ANSI C63.4-1992 when performing the normalized site attenuation measurements.



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APPENDIX C

C. FCC and NVLAP Accreditation





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National Institute
of Standards and Technology

NVLAP[®]

National Voluntary
Laboratory Accreditation Program

ISO/IEC 17025:1999
ISO 9002:1994

Scope of Accreditation



Revised Scope 05/20/2003

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ELECTROMAGNETIC COMPATIBILITY AND TELECOMMUNICATIONS

NVLAP LAB CODE 200116-0

NEMKO USA, INC. - SAN DIEGO EMC DIVISION

11696 Sorrento Valley Road, Suite F

San Diego, CA 92121

Mr. Ricky Hill

Phone: 858-755-5525 x207 Fax: 858-793-9914

E-Mail: ricky.hill@nemkona.com

URL: <http://www.nemkona.com>

NVLAP Code Designation / Description

Emissions Test Methods:

12/CIS14	CISPR 14-1 (March 30, 2000): Limits and methods of measurement of radio interference characteristics of household electrical appliances, portable tools and similar electrical apparatus - Part 1: Emissions
12/CIS14a	EN 55014-1 (1993) with Amendments A1 (1997) & A2 (1999)
12/CIS14b	AS/NZS 1044 (1995)
12/CIS14c	CNS 13783-1
12/CIS22	IEC/CISPR 22 (1997) and EN 55022 (1998): Limits and methods of measurement of radio disturbance characteristics of information technology equipment
12/CIS22a	IEC/CISPR 22 (1993): Limits and methods of measurement of radio disturbance characteristics of information technology equipment, Amendment 1:1995, and Amendment 2:1996.

December 31, 2003

Effective through

For the National Institute of Standards and Technology



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ELECTROMAGNETIC COMPATIBILITY AND TELECOMMUNICATIONS

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NVLAP Code Designation / Description

12/CIS22b	CNS 13438 (1997): Limits and Methods of Measurement of Radio Interference Characteristics of Information Technology Equipment
12/EM02a	IEC 61000-3-2, Edition 2.1 (2001-10) and EN 61000-3-2 (2000) : Electromagnetic compatibility (EMC) Part 3-2: Limits - Limits for harmonic current emissions (equipment input current <= 16 A)
12/EM03b	IEC 61000-3-3 Amendment 1 (2001-01) Electromagnetic Compatib: Part 3-3: Limits - Limitations of voltage changes, voltage flucuations and flicker, in public low-voltage supply-systems, for equipment with rated current <=16 A per phase and not subject to conditional connections
12/F01	ANSI C63.4 (2001) - cited in FCC Method - 47 CFR Part 15 - Digital Devices
12/F01a	Conducted Emissions, Power Lines, 150 KHz to 30 MHz
12/F01b	Radiated Emissions
12/F18	FCC OST/MP-5 (1986): FCC Methods of Measurement of Radio Noise Emissions for ISM Equipment (cited in FCC Method 47 CFR Part 18 - Industrial, Scientific, and Medical Equipment)
12/T51	AS/NZS 3548: Electromagnetic Interference - Limits and Methods of Measurement of Information Technology Equipment

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**ELECTROMAGNETIC COMPATIBILITY
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NEMKO USA, INC. - SAN DIEGO EMC DIVISION

NVLAP Code Designation / Description

Immunity Test Methods:

12/I01	IEC 61000-4-2 (1995) and Amendment 1 (1998): Electrostatic Discharge Immunity Test
12/I02	IEC 61000-4-3 (1995) and Amendment 1 (1998): Radiated, Radio-Frequency Electromagnetic Field Immunity Test
12/I03	IEC 61000-4-4 (1995): Electrical Fast Transient/Burst Immunity Test
12/I04	IEC 61000-4-5 (1995): Surge Immunity Test
12/I05	IEC 61000-4-6 (1996): Immunity to Conducted Disturbances, Induced Radio-Frequency Fields
12/I06	IEC 61000-4-8 (1993): Power Frequency Magnetic Field Immunity Test
12/I07	IEC 61000-4-11 (1994): Voltage Dips, Short Interruptions and Voltage Variations Immunity Tests

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